

Notice of References Cited	Application/Control No. 10/604,721	Applicant(s)/Patent Under Reexamination CHANG ET AL.	
	Examiner Scott Egan	Art Unit 2621	Page 1 of 1

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*	B	US-6,340,114	01-2002	Correa et al.	235/462.22
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NON-PATENT DOCUMENTS

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